

Application/Control No.	Applicant(s)/Patent under Reexamination
10/089,319	AURES ET AL.
Examiner	Art Unit
John L. Shew	2616

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	229,230	7/19/2006	JS
	230.1		
-	231,232		
	233,234		
	235,236		
	395.2		
	395.3		
	395.41		
	468,539		
	541		
379	142.03	7/19/2006	JS
	211.01		
	212.01		
	230		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
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(INCLUDING SEARC	H STRATEGY	′)
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Search Notes (continued)

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Class	Subclass	Date	Examiner
379	265.01	7/19/2006	
	266.04		-
	309		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMF
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